

Search Notes



Application/Control No.

10/812,347

Examiner

Kin-Chan Chen

Applicant(s)/Patent under Reexamination

HIGUCHI ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	706	1/5/2006	KCC
	714		
	715		
438	723		
216	63		
216	74	1/5/2006	KCC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East keyword search USPAT, USPG-pub. Epo, JPO, Derwent IBM-TOB, inventor search	1/5/2006	KCC